Document Number: MRFE6VP8600H
Rev. 1, 9/2011

RoHS

RF Power LDMOS Transistors

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

Optimized for broadband operation from 470 to 860 MHz. Device has an integrated input matching network for better power distribution. These devices are ideally suited for use in analog or digital television transmitters.

- Typical Narrowband Performance: V_{DD} = 50 Volts, I_{DQ} = 1400 mA, Channel Bandwidth = 8 MHz, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF. ACPR measured in 7.61 MHz Signal Bandwidth @ ±4 MHz Offset with an Integration Bandwidth of 4 kHz.

Signal Type	P_{out} (W)	f (MHz)	G_{ps} (dB)	η_D (%)	ACPR (dBc)	IRL (dB)
DVB-T (8k OFDM)	125 Avg.	860	19.3	30.0	-60.5	-12

- Typical Pulsed Broadband Performance: V_{DD} = 50 Volts, I_{DQ} = 1400 mA, Pulsed Width = 100 μsec, Duty Cycle = 10%

Signal Type	P_{out} (W)	f (MHz)	G_{ps} (dB)	η_D (%)
Pulsed	600 Peak	470	19.3	47.1
		650	20.0	53.1
		860	18.8	48.9

Features

- Capable of Handling >65:1 VSWR through all Phase Angles @ 50 Vdc, 860 MHz, DVB-T (8k OFDM) 240 Watts Avg. Output Power (3 dB Input Overdrive from Rated P_{out})
- Exceptional Efficiency for Class AB Analog or Digital Television Operation
- Full Performance across Complete UHF TV Spectrum, 470-860 MHz
- Capable of 600 Watt CW Output Power with Adequate Thermal Management
- Integrated Input Matching
- Extended Negative Gate-Source Voltage Range of -6.0 V to +10 V
  - Improves Class C Performance, e.g. in a Doherty Peaking Stage
  - Enables Fast, Easy and Complete Shutdown of the Amplifier
- Characterized from 20 V to 50 V for Extended Operating Range for use with Drain Modulation
- Excellent Thermal Characteristics
- RoHS Compliant
- In Tape and Reel. R6 Suffix = 150 Units, 56 mm Tape Width, 13 inch Reel. R5 Suffix = 50 Units, 56 mm Tape Width, 13 inch Reel.

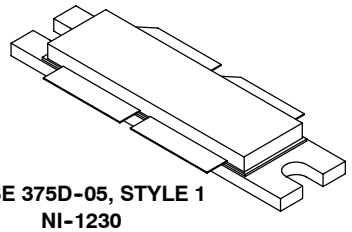
Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +130	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	1052 5.26	W W/°C
Operating Junction Temperature (1,2)	T_J	225	°C

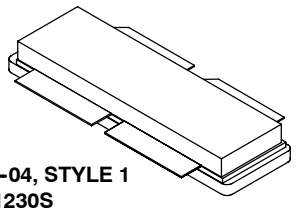
1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

MRFE6VP8600HR6
MRFE6VP8600HR5
MRFE6VP8600HSR6
MRFE6VP8600HSR5

470-860 MHz, 600 W, 50 V
LDMOS BROADBAND
RF POWER TRANSISTORS

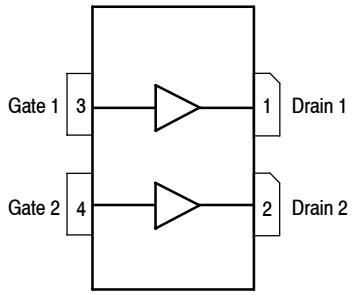


CASE 375D-05, STYLE 1
NI-1230
MRFE6VP8600HR6



CASE 375E-04, STYLE 1
NI-1230S
MRFE6VP8600HSR6

PARTS ARE PUSH-PULL



(Top View)

Note: The backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections

freescale semiconductor

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 74°C, 125 W CW, 50 V, 1400 mA, 860 MHz	$R_{\theta JC}$	0.19 (3)	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (2001-4000 V)
Machine Model (per EIA/JESD22-A115)	B (201-400 V)
Charge Device Model (per JESD22-C101)	IV (>1000 V)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics (4)					
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μAdc
Drain-Source Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 100 mA)	$V_{(BR)DSS}$	130	140	—	Vdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 50 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	5	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 100 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	20	μAdc
On Characteristics					
Gate Threshold Voltage (4) (V_{DS} = 10 Vdc, I_D = 980 μAdc)	$V_{GS(th)}$	1.5	2.07	2.5	Vdc
Gate Quiescent Voltage (5) (V_{DD} = 50 Vdc, I_D = 1400 mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.1	2.65	3.1	Vdc
Drain-Source On-Voltage (4) (V_{GS} = 10 Vdc, I_D = 2 Adc)	$V_{DS(on)}$	—	0.24	—	Vdc
Forward Transconductance (V_{DS} = 10 Vdc, I_D = 20 Adc)	g_{fs}	—	15.6	—	S
Dynamic Characteristics (4)					
Reverse Transfer Capacitance (6) (V_{DS} = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{rss}	—	1.49	—	pF
Output Capacitance (6) (V_{DS} = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{oss}	—	79.9	—	pF
Input Capacitance (7) (V_{DS} = 50 Vdc, V_{GS} = 0 Vdc ± 30 mV(rms)ac @ 1 MHz)	C_{iss}	—	264	—	pF

Functional Tests (5) (In Freescale Narrowband Test Fixture, 50 ohm system) V_{DD} = 50 Vdc, I_{DQ} = 1400 mA, P_{out} = 125 W Avg., f = 860 MHz, DVB-T (8k OFDM) Single Channel. ACPR measured in 7.61 MHz Signal Bandwidth @ ±4 MHz Offset with an Integration Bandwidth of 4 kHz.

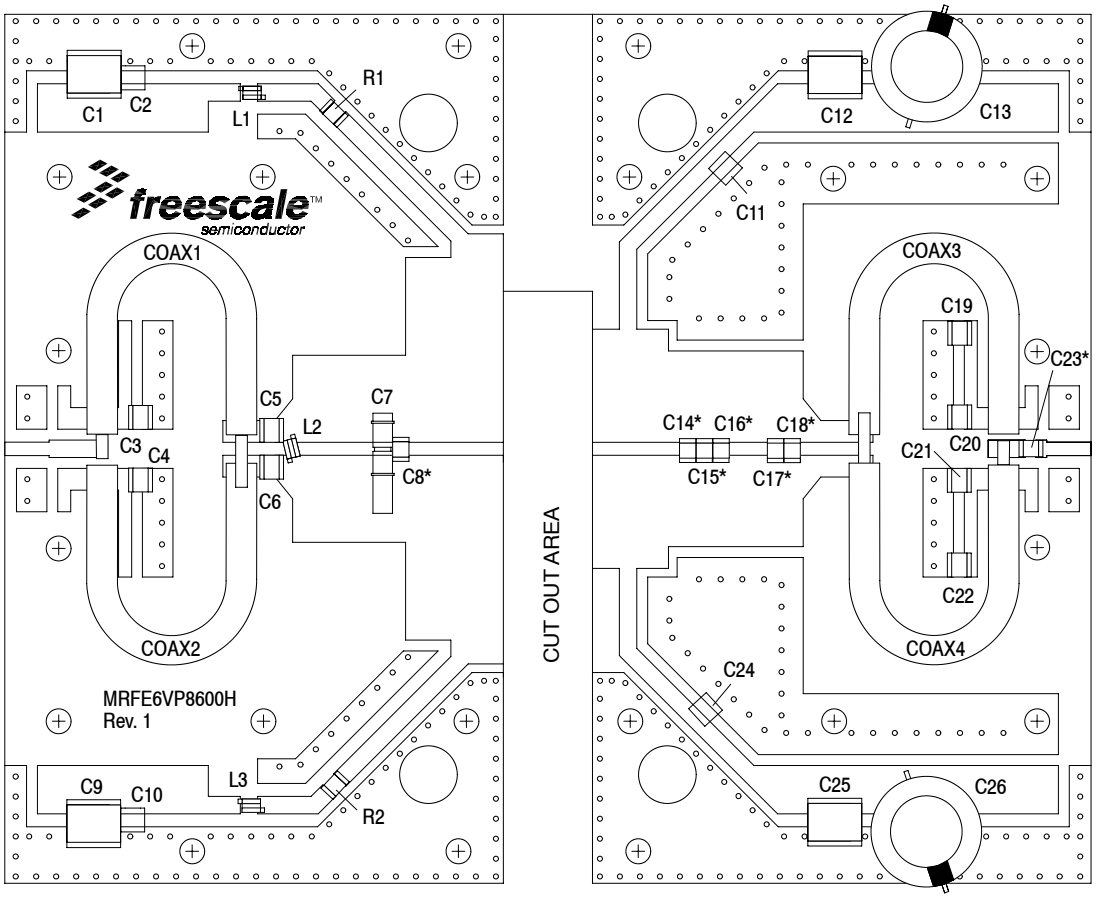
Power Gain	G_{ps}	18.0	19.3	21.0	dB
Drain Efficiency	η_D	29.0	30.0	—	%
Adjacent Channel Power Ratio	ACPR	—	-60.5	-58.5	dBc
Input Return Loss	IRL	—	-12	-9	dB

1. MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.
3. Performance with thermal grease TIM (thermal interface material) will typically degrade by 0.05°C/W due to the increased thermal contact resistance of this TIM.
4. Each side of device measured separately.
5. Measurement made with device in push-pull configuration.
6. Part internally input matched.
7. Die capacitance value without internal matching.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Typical DVB-T (8k OFDM) Performance (In Freescale Narrowband Test Fixture, 50 ohm system) V_{DD} = 50 Vdc, I_{DQ} = 1400 mA, f = 860 MHz, DVB-T (8k OFDM) Single Channel.					
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF, P_{out} = 125 W Avg.	PAR	—	7.8	—	dB
Load Mismatch VSWR >65:1 at all Phase Angles, 3 dB Overdrive from Rated P_{out} (240 W Avg.)	Ψ	No Degradation in Output Power			

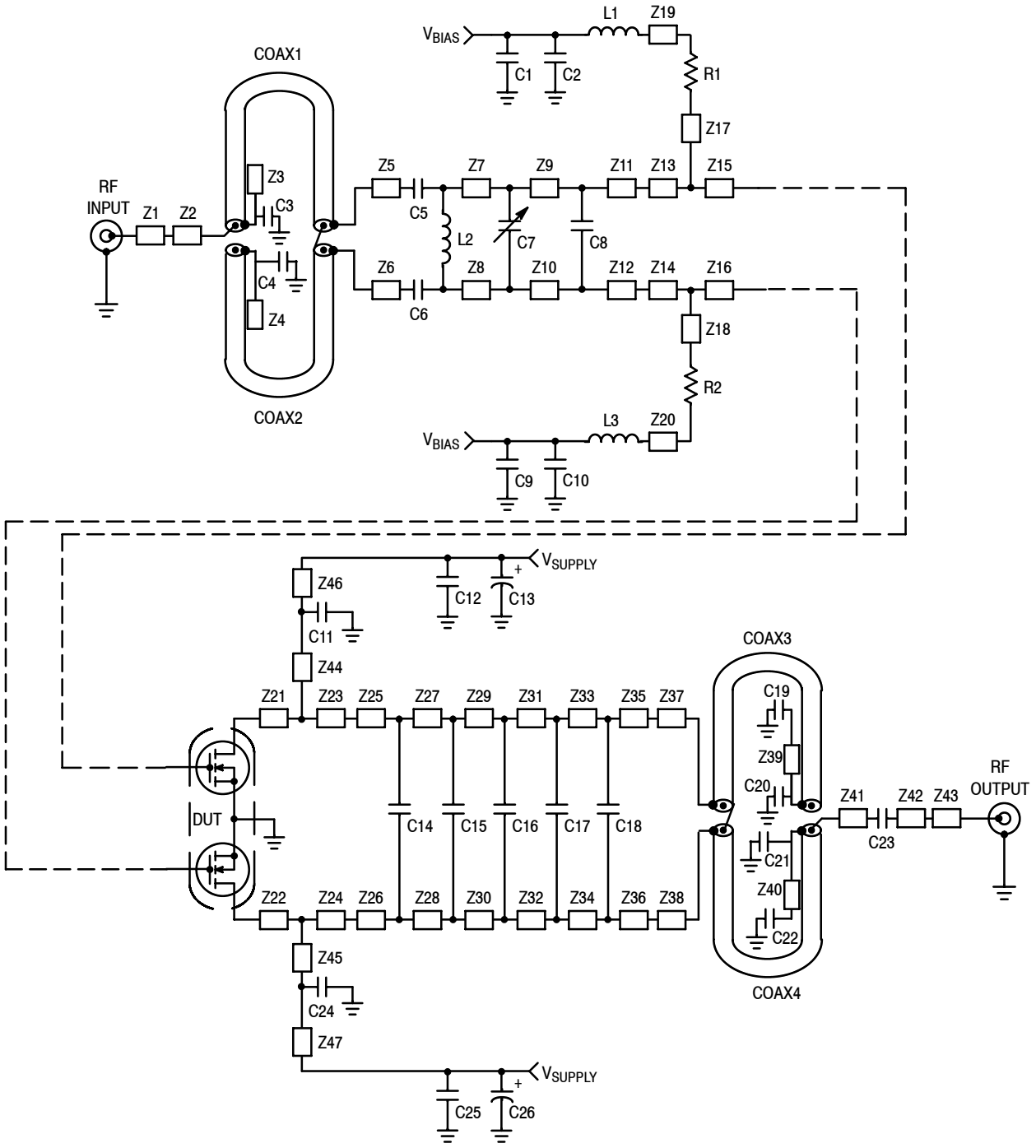


*C8, C14, C15, C16, C17, C18 and C23 are mounted vertically.

Figure 2. MRFE6VP8600HR6(HSR6) Test Circuit Component Layout — 860 MHz, DVB-T (8k OFDM)

Table 5. MRFE6VP8600HR6(HSR6) Test Circuit Component Designations and Values — 860 MHz, DVB-T (8k OFDM)

Part	Description	Part Number	Manufacturer
C1, C9	10 μF, 50 V, Chip Capacitors	GRM55DR61H106KA88L	Murata
C2, C10	2.2 μF, 50 V, Chip Capacitors	C3225X7R1H225K	TDK
C3, C4, C20, C21, C23	100 pF Chip Capacitors	ATC100B101JT500XT	ATC
C5, C6	24 pF Chip Capacitors	ATC100B240JT500XT	ATC
C7	0.8–8.0 pF Variable Capacitor	27291SL	Johanson Components
C8	12 pF Chip Capacitor	ATC100B120JT500XT	ATC
C11, C24	2.2 μF, 100 V, Chip Capacitors	C3225X7R2A225KT	TDK
C12, C25	4.7 μF, 100 V, Chip Capacitors	GRM55ER72A475KA01B	Murata
C13, C26	470 μF, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
C14	6.8 pF Chip Capacitor	ATC100B6R8CT500XT	ATC
C15	3.0 pF Chip Capacitor	ATC100B3R0CT500XT	ATC
C16	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C17	3.9 pF Chip Capacitor	ATC100B3R9CT500XT	ATC
C18	5.1 pF Chip Capacitor	ATC100B5R1CT500XT	ATC
C19, C22	1000 pF Chip Capacitors	ATC100B102JT50XT	ATC
Coax1, 2, 3, 4	25 Ω SemiRigid Coax, Length 2.0”	UT-141C-25	Micro-Coax
L1, L3	5.0 nH, 2 Turn Inductors	A02TKLC	Coilcraft
L2	2.5 nH, 1 Turn Inductor	A01TKLC	Coilcraft
R1, R2	10 Ω, 1/4 W Chip Resistors	CRCW120610R0JNEA	Vishay
PCB	0.030″, ε_r = 3.5	RO4350B	Rogers



Z1	0.204″ x 0.062″ Microstrip	Z17, Z18	0.780″ x 0.080″ Microstrip	Z35, Z36	0.052″ x 0.420″ Microstrip
Z2	0.245″ x 0.080″ Microstrip	Z19*, Z20*	0.354″ x 0.080″ Microstrip	Z37, Z38	0.211″ x 0.100″ Microstrip
Z3, Z4	0.445″ x 0.060″ Microstrip	Z21, Z22	0.164″ x 0.520″ Microstrip	Z39, Z40	0.389″ x 0.060″ Microstrip
Z5, Z6	0.019″ x 0.100″ Microstrip	Z23, Z24	0.186″ x 0.520″ Microstrip	Z41	0.070″ x 0.080″ Microstrip
Z7, Z8	0.415″ x 0.400″ Microstrip	Z25, Z26	0.088″ x 0.420″ Microstrip	Z42	0.018″ x 0.080″ Microstrip
Z9, Z10	0.083″ x 0.400″ Microstrip	Z27, Z28	0.072″ x 0.420″ Microstrip	Z43	0.204″ x 0.062″ Microstrip
Z11, Z12	0.022″ x 0.400″ Microstrip	Z29, Z30	0.072″ x 0.420″ Microstrip	Z44*, Z45*	0.850″ x 0.080″ Microstrip
Z13, Z14	0.208″ x 0.850″ Microstrip	Z31, Z32	0.259″ x 0.420″ Microstrip	Z46, Z47	0.250″ x 0.080″ Microstrip
Z15, Z16	0.242″ x 0.960″ Microstrip	Z33, Z34	0.075″ x 0.420″ Microstrip		

* Line length includes microstrip bends

Figure 3. MRFE6VP8600HR6(HSR6) Test Circuit Schematic — 860 MHz, DVB-T (8k OFDM)

TYPICAL CHARACTERISTICS — 860 MHz

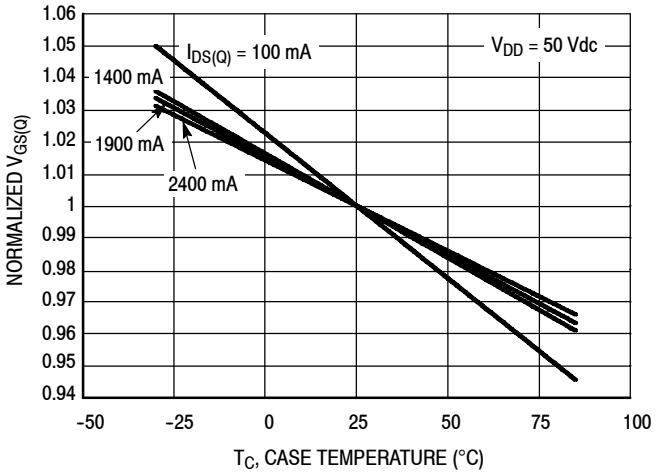
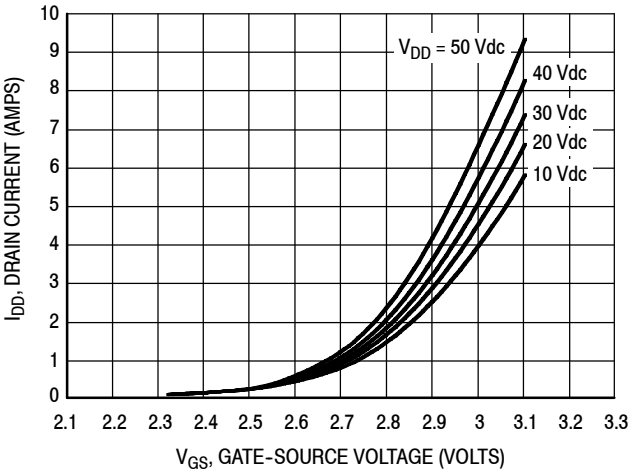
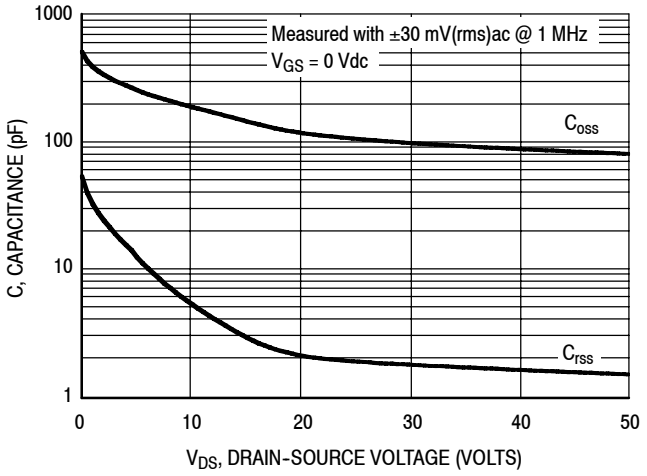


Figure 4. Normalized V_{GS} Quiescent versus Case Temperature



Note: Measured with both sides of the transistor tied together.

Figure 5. Drain Current versus Gate-Source Voltage



Note: Each side of device measured separately.

Figure 6. Capacitance versus Drain-Source Voltage

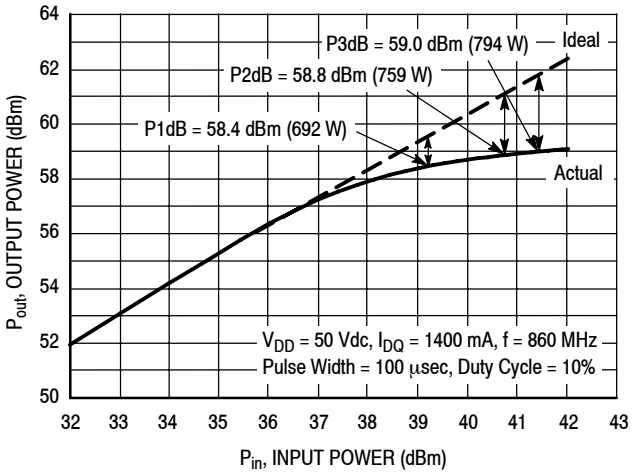


Figure 7. Pulsed CW Output Power versus Input Power

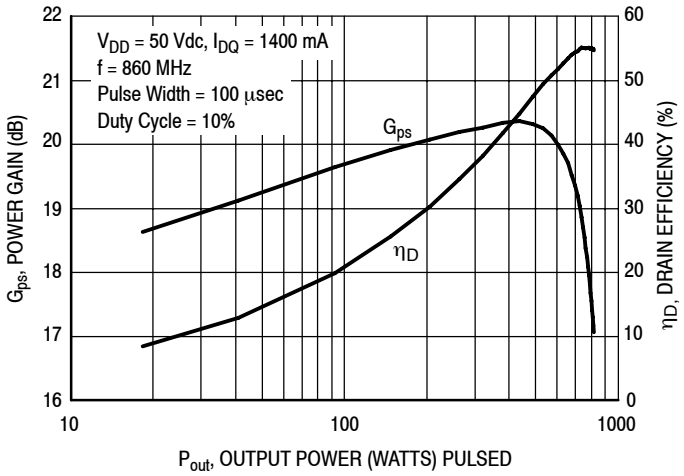


Figure 8. Pulsed Power Gain and Drain Efficiency versus Output Power

TYPICAL CHARACTERISTICS — DVB-T (8k OFDM)

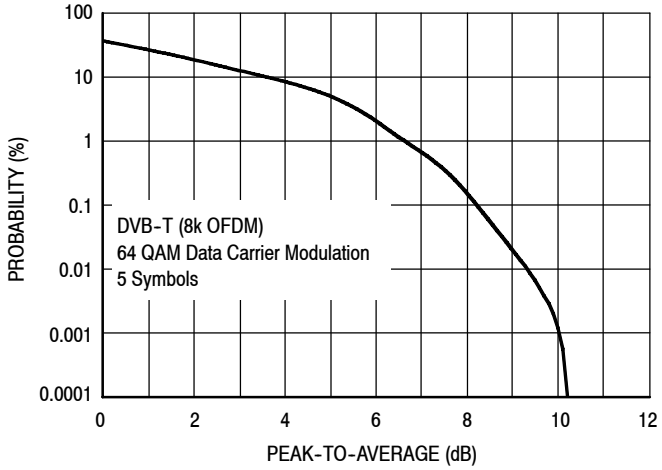


Figure 9. Source Peak-to-Average DVB-T (8k OFDM)

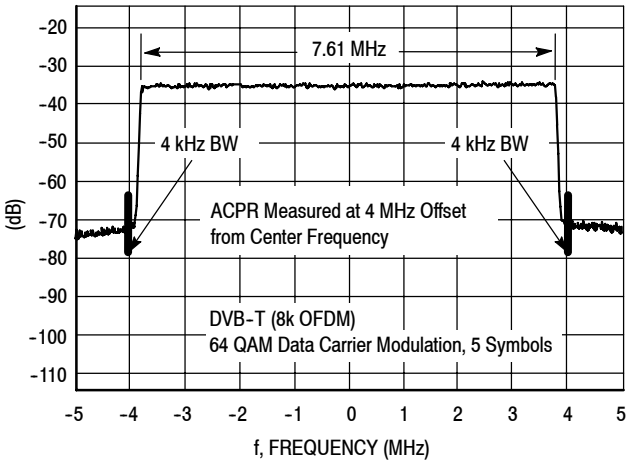


Figure 10. DVB-T (8k OFDM) Spectrum

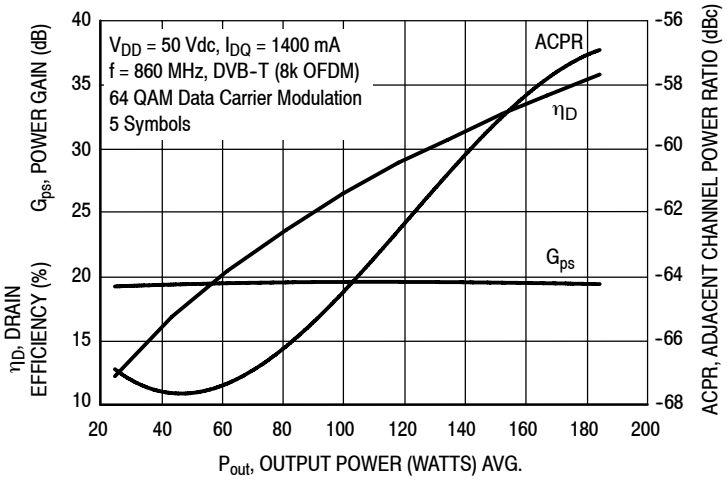
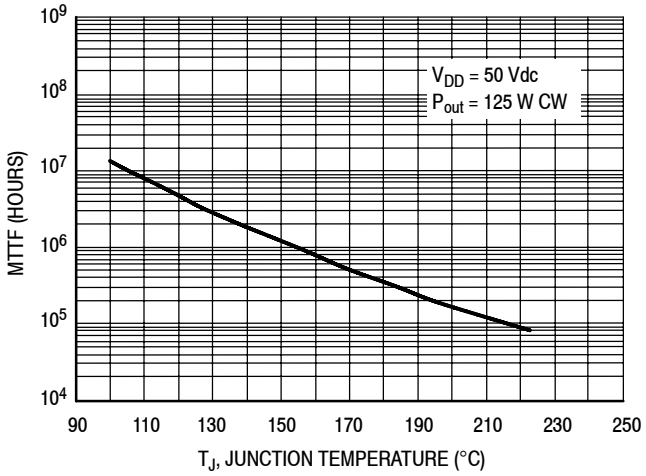


Figure 11. Single-Carrier DVB-T (8k OFDM) Drain Efficiency, Power Gain and ACPR versus Output Power

TYPICAL CHARACTERISTICS



Note: The MTTF calculation for this graph is based on the thermal resistance of the part using thermal grease TIM mounting.

MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 12. MTTF versus Junction Temperature - CW

V_{DD} = 50 Vdc, I_{DQ} = 1400 mA, P_{out} = 125 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
860	1.14 + j0.88	2.61 + j1.84

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

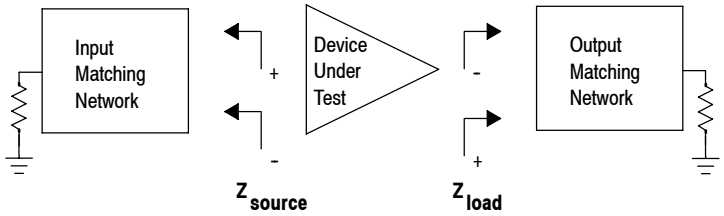
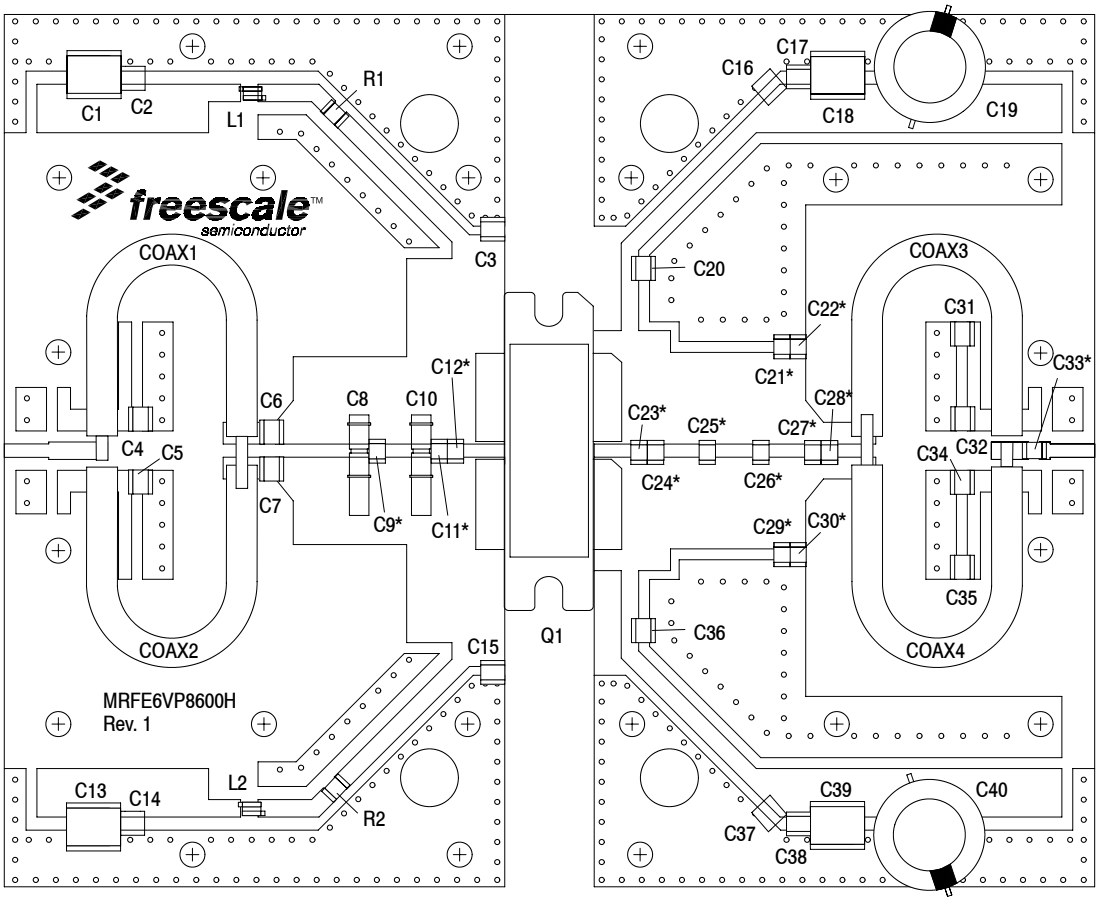


Figure 13. Series Equivalent Source and Load Impedance

470–860 MHz REFERENCE CIRCUIT

V_{DD} = 50 Volts, I_{DQ} = 1400 mA, Channel Bandwidth = 8 MHz, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF, T_C = 50°C.

Signal Type	P_{out} (W)	f (MHz)	G_{ps} (dB)	η_D (%)	Output PAR (dB)	IMD Shoulder (dBc)
DVB–T (8k OFDM)	125 Avg.	470	19.0	27.2	8.2	–31.1
		650	20.3	30.6	7.6	–30.3
		860	19.0	27.9	7.7	–30.4



*C9, C11, C12, C21, C22, C23, C24, C25, C26, C27, C28, C29, C30 and C33 are mounted vertically.

Figure 14. MRFE6VP8600HR6(HSR6) Broadband Test Circuit Component Layout — 470–860 MHz

470–860 MHz REFERENCE CIRCUIT

Table 6. MRFE6VP8600HR6(HSR6) Broadband Test Circuit Component Designations and Values — 470–860 MHz

Part	Description	Part Number	Manufacturer
C1, C13	10 μF, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C2, C14	2.2 μF, 50 V Chip Capacitors	C3225X7R1H225K	TDK
C3, C15	10 pF Chip Capacitors	ATC100B100JT500XT	ATC
C4, C5	47 pF Chip Capacitors	ATC100B470JT500XT	ATC
C6, C7	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C8, C10	0.8–8.0 pF Variable Capacitors	27291SL	Johanson Components
C9, C28	8.2 pF Chip Capacitors	ATC100B8R2CT500XT	ATC
C11, C12	6.8 pF Chip Capacitors	ATC800B6R8BT500XT	ATC
C16, C37	39,000 pF Chip Capacitors	ATC200B393KT50XT	ATC
C17, C38	2.2 μF, 100 V Chip Capacitors	C3225X7R2A225KT	TDK
C18, C39	4.7 μF, 100 V Chip Capacitors	GRM55ER72A475KA01B	Murata
C19, C40	220 μF, 100 V Electrolytic Capacitors	EEV-FK2A221M	Panasonic-ECG
C20, C36	56 pF Chip Capacitors	ATC100B560CT500XT	ATC
C21, C25, C29	7.5 pF Chip Capacitors	ATC800B7R5CT500XT	ATC
C22, C30	8.2 pF Chip Capacitors	ATC800B8R2CT500XT	ATC
C23	13 pF Chip Capacitor	ATC800B130JT500XT	ATC
C24	9.1 pF Chip Capacitor	ATC800B9R1CT500XT	ATC
C26	3.3 pF Chip Capacitor	ATC800B3R3CT500XT	ATC
C27	3.9 pF Chip Capacitor	ATC100B3R9CT500XT	ATC
C31, C35	1,000 pF Chip Capacitors	ATC100B102JT50XT	ATC
C32, C33, C34	120 pF Chip Capacitors	ATC100B121JT500XT	ATC
L1, L2	5.0 nH, 2 Turn Inductors	A02TKLC	Coilcraft
R1, R2	10 Ω, 1/4 W Chip Resistors	CRCW120610R0JNEA	Vishay
Coax1, 2, 3, 4	25 Ω SemiRigid Coax, Length 2.0″	UT-141C-25	Micro-Coax
Q1	RF Power LDMOS Transistor	MRFE6VP8600HR6	Freescale
PCB	0.030″, ε_r = 3.5	RO4350B	Rogers

Table 7. MRFE6VP8600HR6(HSR6) Broadband Test Circuit Microstrips — 470–860 MHz

Microstrip	Description
Z1	0.204″ x 0.062″ Microstrip
Z2	0.245″ x 0.080″ Microstrip
Z3, Z4	0.445″ x 0.060″ Microstrip
Z5, Z6	0.019″ x 0.100″ Microstrip
Z7, Z8	0.305″ x 0.400″ Microstrip
Z9, Z10	0.083″ x 0.400″ Microstrip
Z11, Z12	0.095″ x 0.400″ Microstrip
Z13, Z14	0.055″ x 0.850″ Microstrip
Z15, Z16	0.083″ x 0.850″ Microstrip
Z17, Z18	0.071″ x 0.850″ Microstrip
Z19, Z20	0.187″ x 0.960″ Microstrip
Z21, Z22	0.055″ x 0.960″ Microstrip
Z23, Z24	0.780″ x 0.080″ Microstrip
Z25*, Z26*	0.354″ x 0.080″ Microstrip
Z27, Z28	0.164″ x 0.520″ Microstrip
Z29, Z30	0.074″ x 0.520″ Microstrip
Z31, Z32	0.075″ x 0.520″ Microstrip
Z33, Z34	0.038″ x 0.520″ Microstrip
Z35, Z36	0.170″ x 0.420″ Microstrip
Z37, Z38	0.269″ x 0.420″ Microstrip
Z39, Z40	0.069″ x 0.420″ Microstrip
Z41, Z42	0.075″ x 0.420″ Microstrip
Z43, Z44	0.038″ x 0.420″ Microstrip
Z45, Z46	0.038″ x 0.100″ Microstrip
Z47, Z48	0.075″ x 0.100″ Microstrip
Z49, Z50	0.169″ x 0.100″ Microstrip
Z51, Z52	0.389″ x 0.060″ Microstrip
Z53	0.070″ x 0.080″ Microstrip
Z54	0.018″ x 0.080″ Microstrip
Z55	0.204″ x 0.062″ Microstrip
Z56, Z57	0.278″ x 0.080″ Microstrip
Z58*, Z59*	0.886″ x 0.080″ Microstrip

* Line length includes microstrip bends

470–860 MHz REFERENCE CIRCUIT

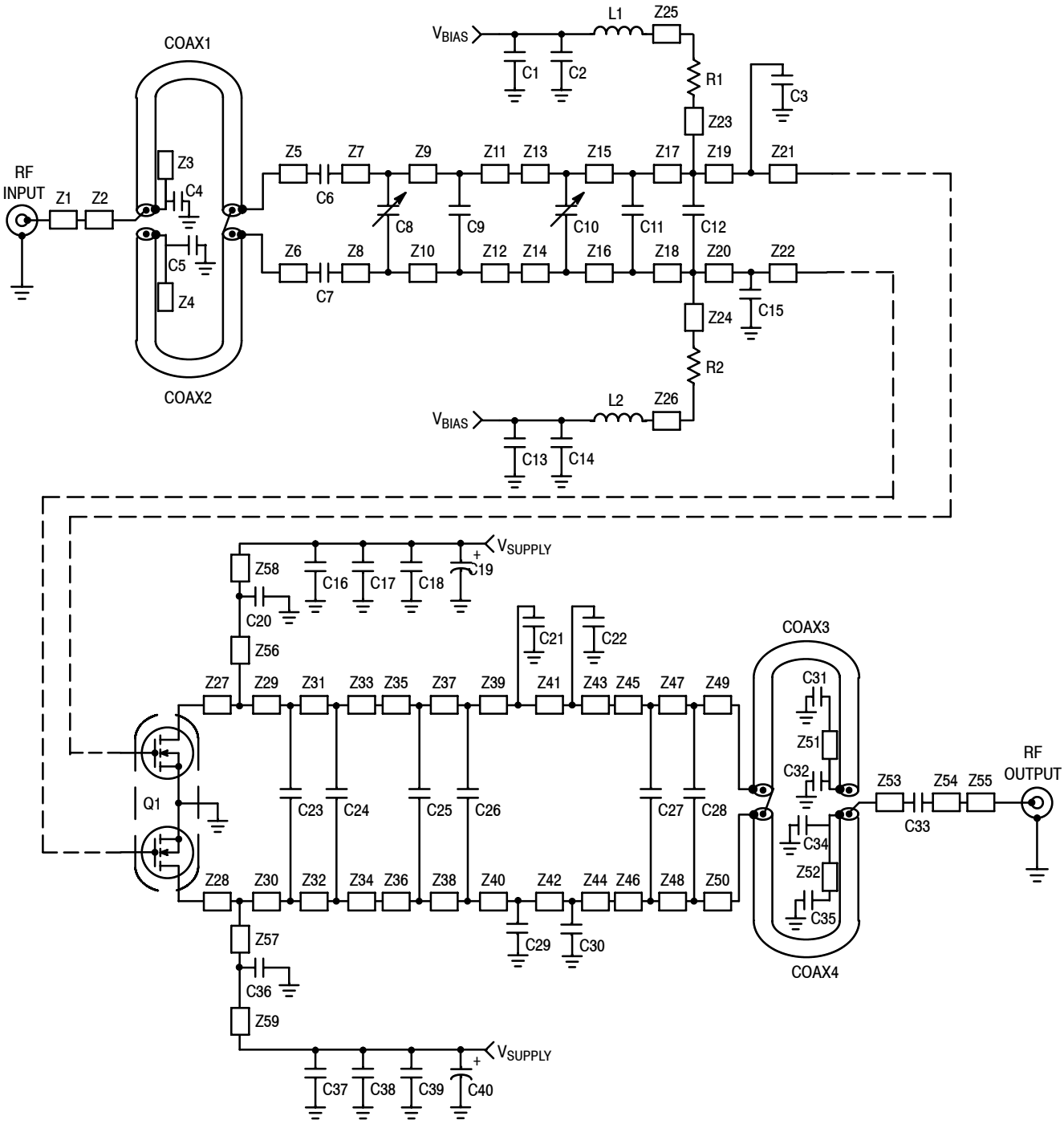


Figure 15. MRFE6VP8600HR6(HSR6) Broadband Test Circuit Schematic — 470–860 MHz

TYPICAL CHARACTERISTICS — 470–860 MHz REFERENCE CIRCUIT

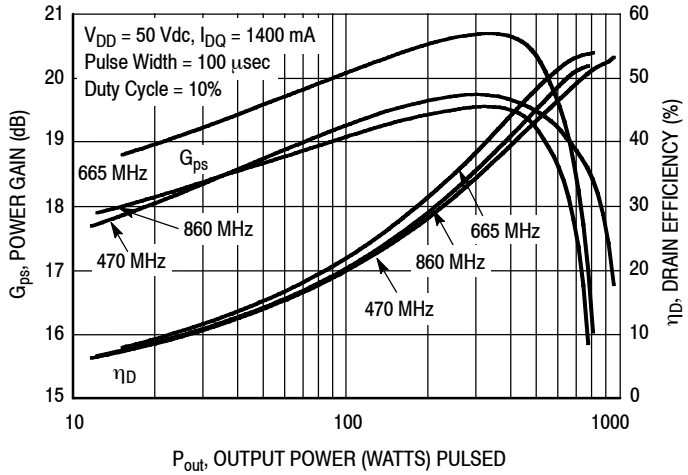


Figure 16. Broadband Pulsed Power Gain and Drain Efficiency versus Output Power — 470–860 MHz

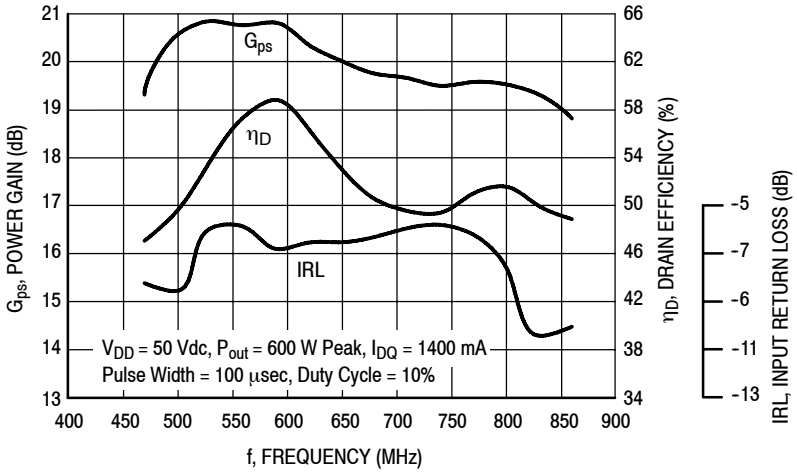
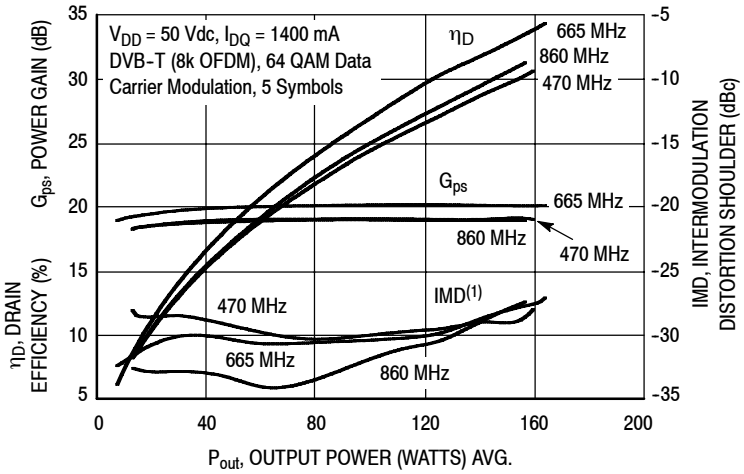


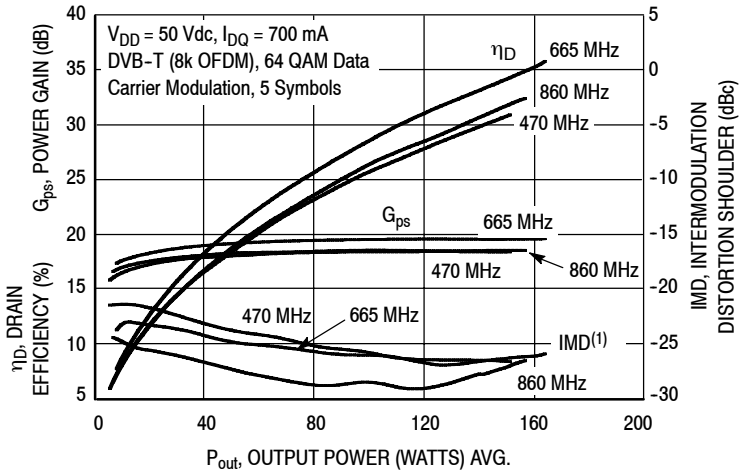
Figure 17. Broadband Pulsed Power Gain, Drain Efficiency and IRL versus Frequency



(1) Intermodulation distortion shoulder measurement made using delta marker at 4.2 MHz offset from center frequency.

Figure 18. DVB-T (8k OFDM) Drain Efficiency, Power Gain and IMD Shoulder versus Output Power — 470–860 MHz

TYPICAL CHARACTERISTICS — 470–860 MHz REFERENCE CIRCUIT



(1) Intermodulation distortion shoulder measurement made using delta marker at 4.2 MHz offset from center frequency.

Figure 19. DVB-T (8k OFDM) Drain Efficiency, Power Gain and IMD Shoulder versus Output Power — 470–860 MHz

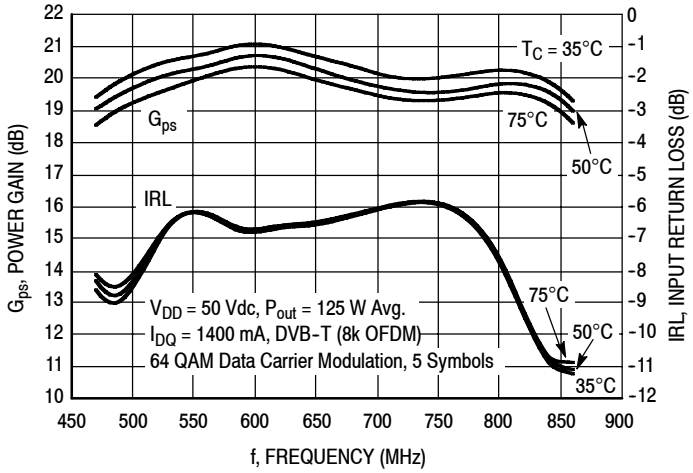
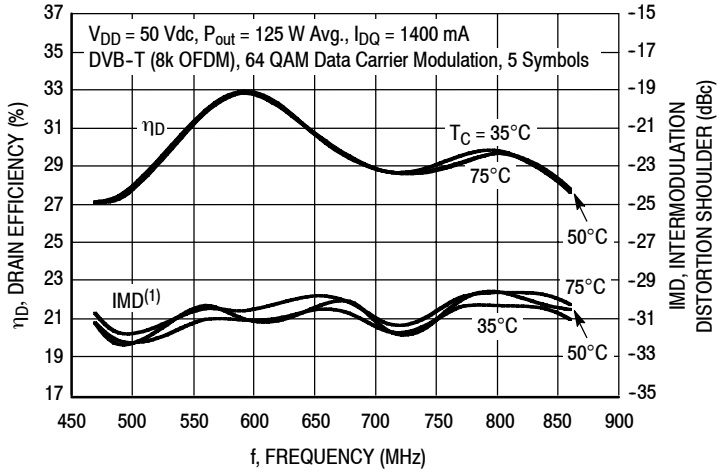


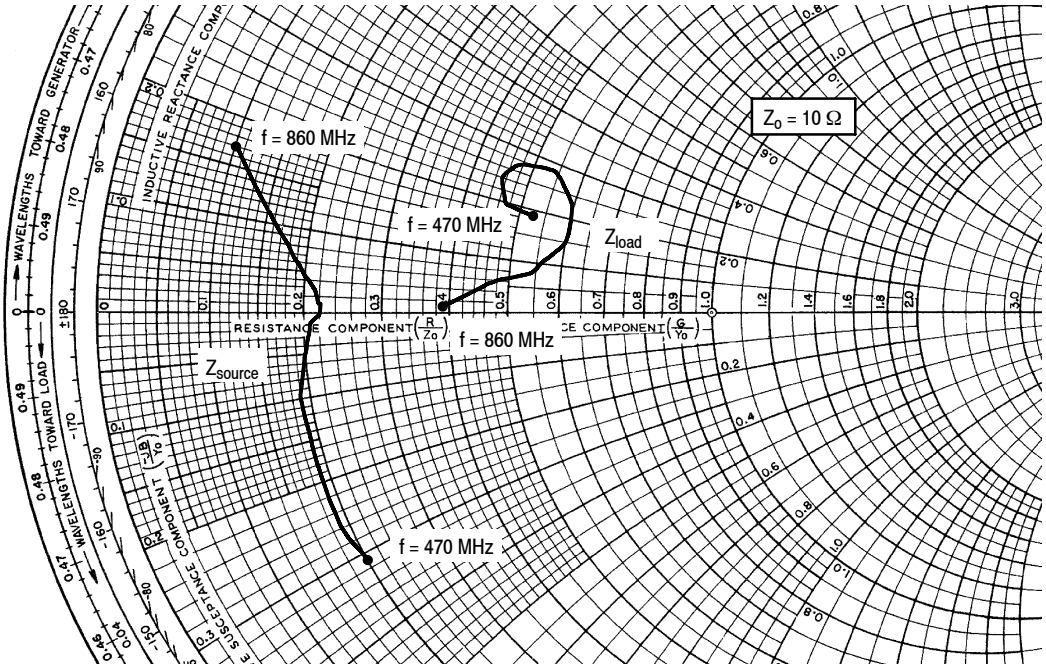
Figure 20. Broadband Power Gain and IRL versus Frequency



(1) Intermodulation distortion shoulder measurement made using delta marker at 4.2 MHz offset from center frequency.

Figure 21. Broadband Drain Efficiency and IMD Shoulder versus Frequency

470–860 MHz REFERENCE CIRCUIT



V_{DD} = 50 Vdc, I_{DQ} = 1400 mA, P_{out} = 125 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
470	1.96 – j3.13	5.30 + j1.92
500	1.91 – j2.46	4.65 + j1.95
530	1.88 – j1.86	4.50 + j2.35
560	1.91 – j1.37	4.71 + j2.66
590	1.93 – j0.94	5.40 + j2.75
620	1.99 – j0.49	5.93 + j2.29
650	2.11 – j0.14	6.03 + j1.81
680	2.17 + j0.02	6.04 + j1.45
710	2.14 + j0.26	5.58 + j0.95
740	2.11 + j0.32	5.37 + j0.80
770	1.92 + j0.56	4.80 + j0.56
800	1.65 + j0.91	4.78 + j0.55
830	1.50 + j1.07	4.59 + j0.45
860	0.95 + j1.72	3.93 + j0.11

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

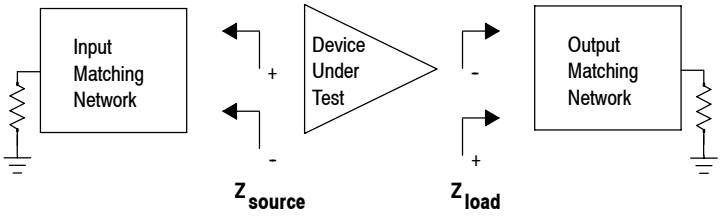
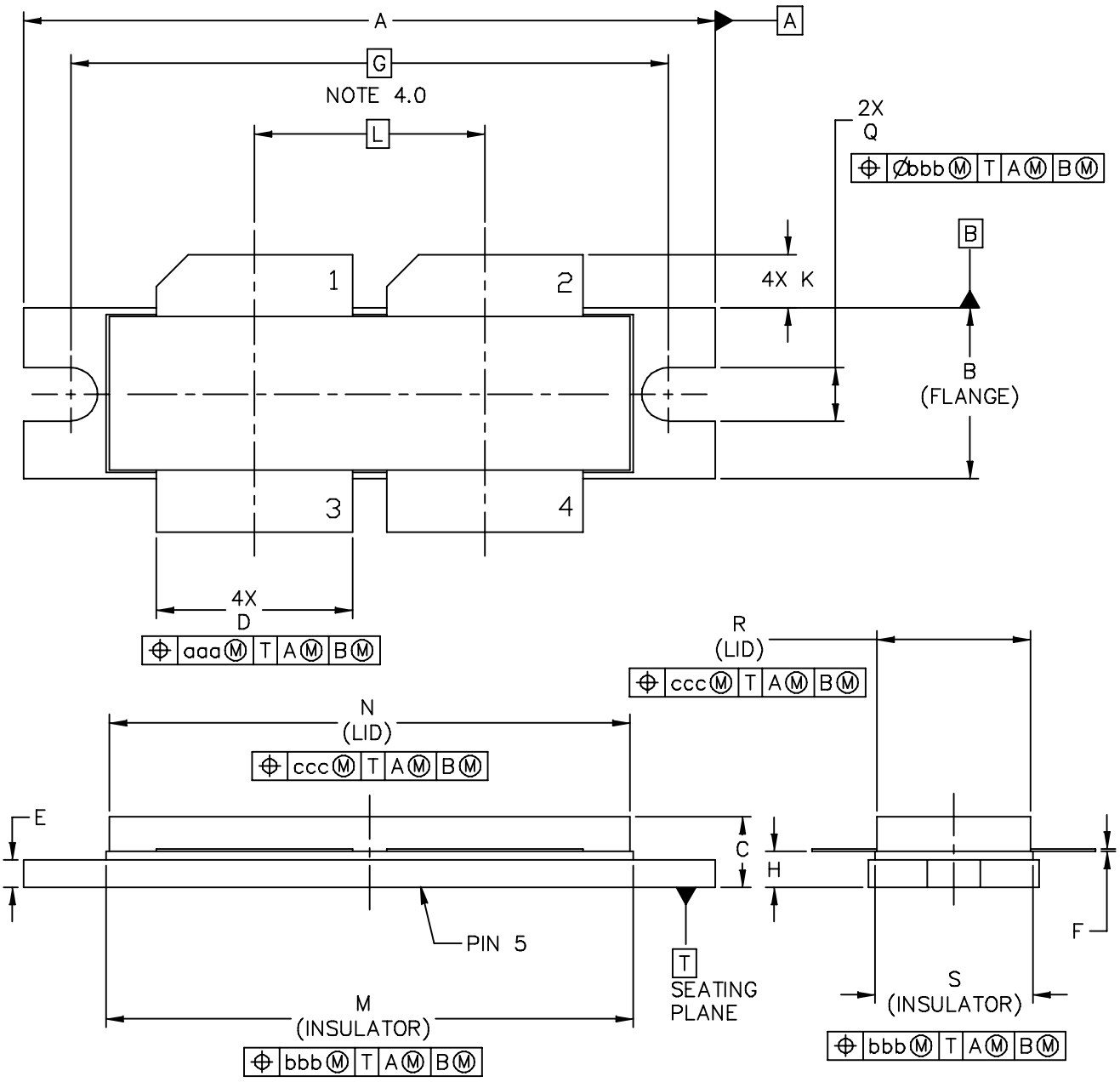


Figure 22. Broadband Series Equivalent Source and Load Impedance — 470–860 MHz

PACKAGE DIMENSIONS



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TITLE: NI−1230	DOCUMENT NO: 98ASB16977C	REV: E
	CASE NUMBER: 375D−05	31 MAR 2005
	STANDARD: NON−JEDEC	

NOTES:

1. 0 INTERPRET DIMENSIONS AND TOLERANCES
PER ASME Y14. 5M–1994.

2. 0 CONTROLLING DIMENSION: INCH

3. 0 DIMENSION H IS MEASURED . 030 (0. 762)
AWAY FROM PACKAGE BODY.

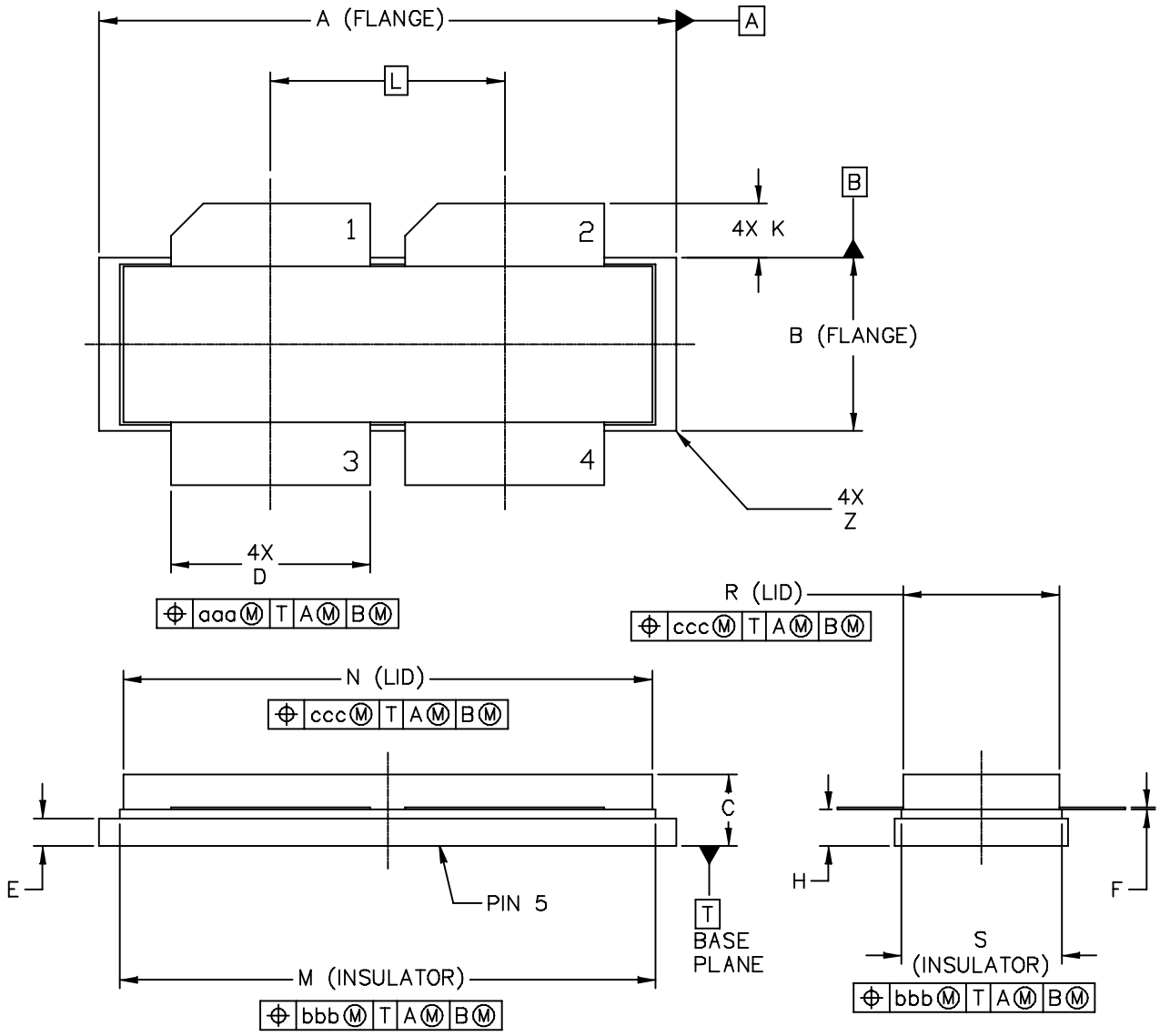
4. 0 RECOMMENDED BOLT CENTER DIMENSION OF
1. 52 (38. 61) BASED ON M3 SCREW.

STYLE 1:
PIN 1 – DRAIN
2 – DRAIN
3 – GATE
4 – GATE
5 – SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55
B	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.3
C	.150	.200	3.81	5.08	R	.355	.365	9.01	9.27
D	.455	.465	11.56	11.81	S	.365	.375	9.27	9.53
E	.062	.066	1.57	1.68					
F	.004	.007	0.1	0.18					
G	1.400 BSC		35.56 BSC		aaa	.013		0.33	
H	.082	.090	2.08	2.29	bbb	.010		0.25	
K	.117	.137	2.97	3.48	ccc	.020		0.51	
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					

MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE

TITLE:	DOCUMENT NO: 98ASB16977C	REV: E
NI–1230	CASE NUMBER: 375D–05	31 MAR 2005
	STANDARD: NON–JEDEC	



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	CASE NUMBER: 375E–04	05 AUG 2005
	STANDARD: NON–JEDEC	

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.

2. CONTROLLING DIMENSION: INCH

3. DIMENSION H IS MEASURED .030 AWAY FROM PACKAGE BODY

STYLE 1:
PIN 1 – DRAIN
2 – DRAIN
3 – GATE
4 – GATE
5 – SOURCE

DIM	INCHES MIN	INCHES MAX	MILLIMETERS MIN	MILLIMETERS MAX	DIM	INCHES MIN	INCHES MAX	MILLIMETERS MIN	MILLIMETERS MAX
A	1.265	1.275	32.13	32.38	R	.355	.365	9.01	9.27
B	.395	.405	10.03	10.29	S	.365	.375	9.27	9.53
C	.150	.200	3.81	5.08	Z	---	.040	---	1.02
D	.455	.465	11.56	11.81					
E	.062	.066	1.57	1.68	aaa	.013		0.33	
F	.004	.007	0.1	0.18	bbb	.010		0.25	
H	.082	.090	2.08	2.29	ccc	.020		0.51	
K	.117	.137	2.97	3.48					
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					
N	1.218	1.242	30.94	31.55					

MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE

TITLE:	DOCUMENT NO: 98ARB18247C	REV: F
NI–1230S	CASE NUMBER: 375E–04	05 AUG 2005
	STANDARD: NON–JEDEC	

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following documents to aid your design process.

Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Sept. 2011	• Initial Release of Data Sheet
1	Sept. 2011	• Added Fig. 19, DVB-T (8k OFDM) Drain Efficiency, Power Gain and IMD Shoulder versus Output Power – 470–860 MHz @ 700 mA to indicate efficiency gains with appropriate precorrection systems, p. 13

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